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NPN Silicon RF Transistor

- Low current device suitable e.g. for handhelds
- For high frequency oscillators e.g. DRO for LNB
- For ISM band applications like
 Automatic Meter Reading, Sensors etc.
- Transit frequency f_T = 25 GHz
- Pb-free (RoHS compliant) package
- Qualified according AEC Q101





ESD (Electrostatic discharge) sensitive device, observe handling precaution!

Туре	Marking	Pin Configuration			Package			
BFP410	AKs	1=B	2=E	3=C	4=E	-	-	SOT343

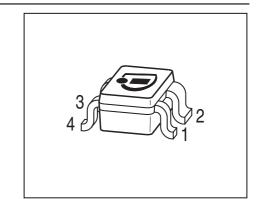
Maximum Ratings at T_A = 25 °C, unless otherwise specified

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V_{CEO}		V
T _A = 25 °C		4.5	
<i>T</i> _A = -55 °C		4.1	
Collector-emitter voltage	V_{CES}	13	
Collector-base voltage	V_{CBO}	13	
Emitter-base voltage	V _{EBO}	1.5	
Collector current	I _C	40	mA
Base current	I_{B}	6	
Total power dissipation ¹⁾	P _{tot}	150	mW
<i>T</i> _S ≤ 100 °C			
Junction temperature	TJ	150	°C
Ambient temperature	T _A	-55 150	
Storage temperature	T_{Stg}	-55 150	

 $^{^1}T_{\mbox{S}}$ is measured on the emitter lead at the soldering point to the pcb

Thermal Resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ¹⁾	R _{thJS}	335	K/W





Electrical Characteristics at $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics				•	•
Collector-emitter breakdown voltage	$V_{(BR)CEO}$	4.5	5	-	V
$I_{\rm C} = 1 \text{ mA}, I_{\rm B} = 0$					
Collector-emitter cutoff current	I _{CES}				nA
$V_{CE} = 2 \text{ V}, V_{BE} = 0$		-	1	30	
$V_{CE} = 5 \text{ V}, V_{BE} = 0 , T_A = 85 ^{\circ}\text{C}$		-	2	50	
(verified by random sampling)					
Collector-base cutoff current	I _{CBO}	-	1	30	
$V_{\rm CB} = 2 \text{ V}, I_{\rm E} = 0$					
Emitter-base cutoff current	I _{EBO}	1	0.001	0.6	μA
$V_{\rm EB} = 0.5 \text{V}, I_{\rm C} = 0$					
DC current gain	h _{FE}	60	95	130	-
$I_{\rm C}$ = 13 mA, $V_{\rm CE}$ = 2 V, pulse measured					

 $^{^{1}\}mbox{For calculation of}~R_{\mbox{\scriptsize thJA}}$ please refer to Application Note Thermal Resistance



Electrical Characteristics at $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
AC Characteristics (verified by random sampling	g)				
Transition frequency	f_{T}	18	25	-	GHz
$I_{\rm C}$ = 20 mA, $V_{\rm CE}$ = 2 V, f = 2 GHz					
Collector-base capacitance	C _{cb}	-	0.09	0.17	pF
$V_{CB} = 2 \text{ V}, f = 1 \text{ MHz}, V_{BE} = 0$,					
emitter grounded					
Collector emitter capacitance	C _{ce}	-	0.35	-	
$V_{CE} = 2 \text{ V}, f = 1 \text{ MHz}, V_{BE} = 0$,					
base grounded					
Emitter-base capacitance	C _{eb}	-	0.45	-	
$V_{\text{EB}} = 0.5 \text{ V}, f = 1 \text{ MHz}, V_{\text{CB}} = 0$,					
collector grounded					
Noise figure	F	-	1.2	-	dB
I_{C} = 2 mA, V_{CE} = 2 V, f = 2 GHz, Z_{S} = Z_{Sopt}					
Power gain, maximum stable ¹⁾	G _{ms}	-	21.5	-	dB
$I_{\rm C}$ = 20 mA, $V_{\rm CE}$ = 2 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$,					
$Z_{L} = Z_{Lopt}$, $f = 2 \text{ GHz}$					
Insertion power gain	$ S_{21} ^2$	-	18.5	-	
$V_{CE} = 2 \text{ V}, I_{C} = 20 \text{ mA}, f = 2 \text{ GHz},$					
$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$					
Third order intercept point at output ²⁾	IP ₃	-	23.5	-	dBm
$V_{CE} = 2 \text{ V}, I_{C} = 20 \text{ mA}, f = 2 \text{ GHz},$					
$Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$					
1dB Compression point at output	P _{-1dB}	-	10.5	-]
$I_{\rm C}$ = 20 mA, $V_{\rm CE}$ = 2 V, $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω ,					
f = 2 GHz					

 $^{^{1}}G_{ms} = |S_{21} / S_{12}|$

²IP3 value depends on termination of all intermodulation frequency components.

Termination used for this measurement is 50Ω from 0.1 MHz to 6 GHz



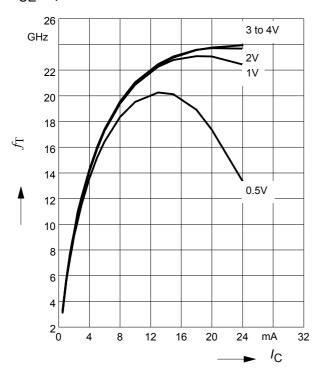
Total power dissipation $P_{\text{tot}} = f(T_{\text{S}})$

180 mW 140 140 100 100 40 20 0 20 40 60 80 100 120 °C 160 Ts

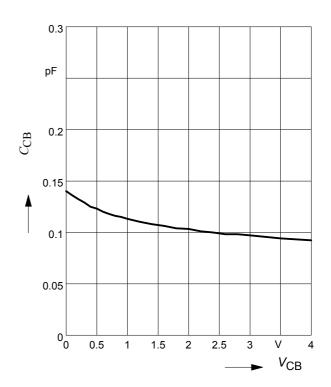
Transition frequency $f_T = f(I_C)$

f = 2 GHz

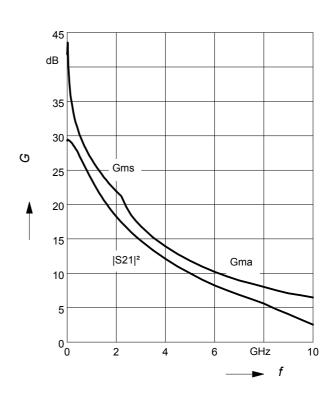
 V_{CE} = parameter in V



Collector-base capacitance C_{cb} = $f(V_{CB})$ f = 1MHz



Power gain G_{ma} , G_{ms} , $|S_{21}|^2 = f(f)$ $V_{CE} = 2 \text{ V}$, $I_C = 13 \text{ mA}$

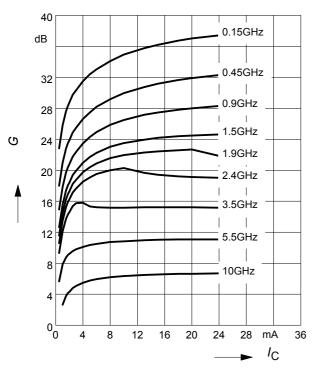




Power gain G_{ma} , $G_{ms} = f(I_C)$

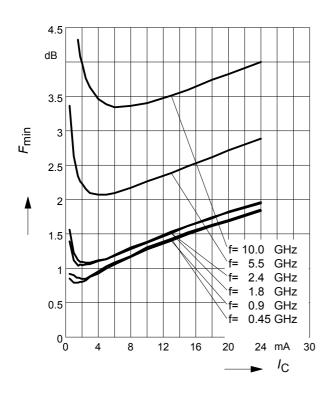
 $V_{CE} = 2V$

f = parameter in GHz



Noise figure $F = f(I_C)$

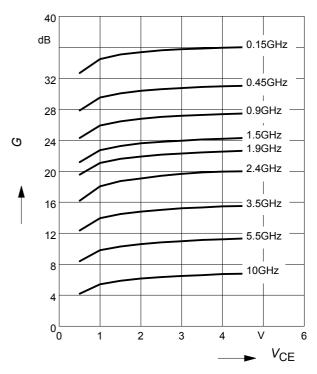
$$V_{CE}$$
 = 2 V, Z_{S} = Z_{Sopt}



Power gain G_{ma} , $G_{ms} = f(V_{CE})$

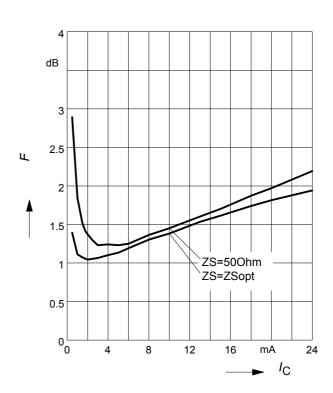
 $I_{\rm C}$ = 13 mA

f = parameter in GHz



Noise figure $F = f(I_{\mathbb{C}})$

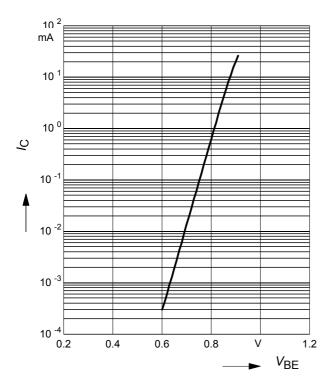
 $V_{CE} = 2 \text{ V}, f = 2 \text{ GHz}$





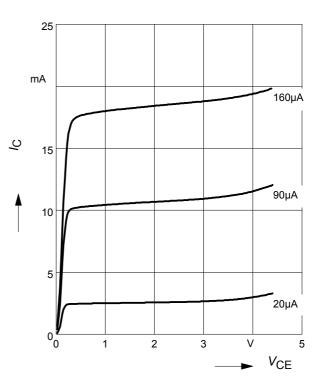
Collector current $I_{C} = f(V_{BE})$

*V*_{CE} =2 V



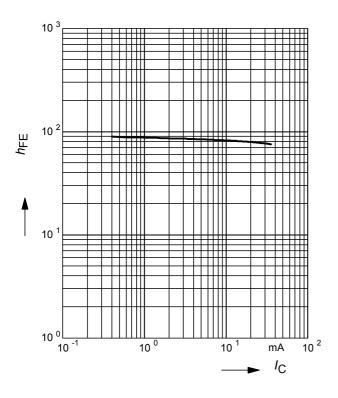
Collector current $I_C = f(V_{CE})$

Parameter $I_{\rm B}$

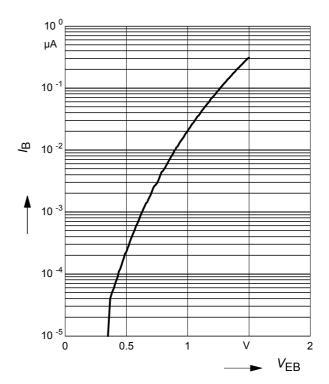


DC current gain $h_{FE} = f(I_C)$

 V_{CE} =2 V



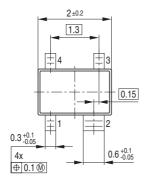
Base current reverse $I_B = f(V_{EB})$

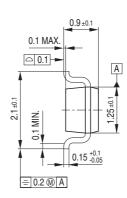




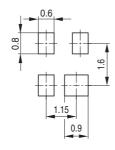
Package Outline



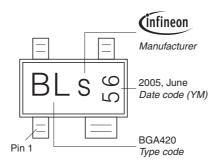




Foot Print

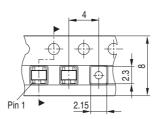


Marking Layout (Example)



Standard Packing

Reel ø180 mm = 3.000 Pieces/Reel Reel ø330 mm = 10.000 Pieces/Reel







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